

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10777363	SUMITOMO ET AL.
	Examiner	Art Unit
	Mackowey, Anthony	2624

SEARCHED

Class	Subclass	Date	Examiner
382	103, 199, 209, 217, 220	4/2/07	AM

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Name Search in PALM	4/2/07	AM
EAST Text Search (US-PGPUB, USPAT, USOCR, EP0, JPO, DERWENT, IBM_TDB) - see search history printout	4/2/07	AM
Text Search IEEE Xplore- see search history printout	4/2/07	AM
Consulted Samir Ahmed, Primary Examiner 2624 regarding pattern recognition and template matching with open curves	4/3/07	AM

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner